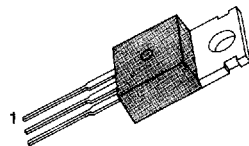


**IRLZ24/20****FEATURES**

- Lower  $R_{DS(ON)}$
- Excellent voltage stability
- Fast switching speeds
- Rugged polysilicon gate cell structure
- Lower input capacitance
- Extended safe operating area
- Improved high temperature reliability
- TO-220 Package

**TO-220**

1. Gate 2. Drain 3. Source

**PRODUCT SUMMARY**

Part Number	$BV_{DSS}$	$R_{DS(on)}$	$I_D$
IRLZ24	60V	$0.15\Omega$	14A
IRLZ20	50V	$0.15\Omega$	14A

**ABSOLUTE MAXIMUM RATINGS**

Characteristic	Symbol	IRLZ24	IRLZ20	Unit
Drain-Source Voltage (1)	$V_{DSS}$	60	50	Vdc
Drain-Gate Voltage ( $R_{GS}=1M\Omega$ )(1)	$V_{DGR}$	60	50	Vdc
Gate-Source Voltage	$V_{GS}$	$\pm 15$		Adc
Continuous Drain Current $T_c=25^\circ C$	$I_D$	14.0		Adc
Continuous Drain Current $T_c=100^\circ C$	$I_D$	9.8		Adc
Drain Current - Pulsed (3)	$I_{DM}$	56		Adc
Total Power Dissipation @ $T_c=25^\circ C$	$P_D$	50		Watts
Derate Above $25^\circ C$		0.33		W/ $^\circ C$
Operating and Storage Junction Temperature Range	$T_J, T_{STG}$	-55 to +175		$^\circ C$
Maximum Lead Temp. for Soldering Purposes, 1/8" from case for 5 seconds	$T_L$	300		$^\circ C$

Notes : (1)  $T_J=25^\circ C$  to  $175^\circ C$ (2) Pulse test : Pulse width  $\leq 300\mu s$ , Duty Cycle  $\leq 2\%$ 

(3) Repetitive rating : Pulse width limited by junction temperature

**IRLZ24/20****N-CHANNEL  
LOGIC LEVEL MOSFET****ELECTRICAL CHARACTERISTICS** (Tc=25°C unless otherwise specified)

Symbol	Characteristic	Min	Typ	Max	Units	Test Conditions
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage					
	IRLZ24	60	-	-	V	V <sub>GS</sub> =0V, I <sub>D</sub> =250 $\mu$ A
	IRLZ20	50	-	-	V	
V <sub>GS(th)</sub>	Gate Threshold Voltage	1.0	-	2.0	V	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =1mA
I <sub>GSS</sub>	Gate-Source Leakage Forward	-	-	100	nA	V <sub>GS</sub> =15V
I <sub>GSS</sub>	Gate-Source Leakage Reverse	-	-	-100	nA	V <sub>GS</sub> =-15V
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	-	-	250	$\mu$ A	V <sub>DS</sub> =Max. Rating, V <sub>GS</sub> =0V
		-	-	1000	$\mu$ A	V <sub>DS</sub> =0.8 Max. Rating, V <sub>GS</sub> =0V, Tc=125°C
R <sub>DS(on)</sub>	Static Drain-Source On-Resistance(2)	-	-	0.15	$\Omega$	V <sub>GS</sub> =5.0V, I <sub>D</sub> =7A
g <sub>fs</sub>	Forward Transconductance (2)	2.0	-	-	S	V <sub>DS</sub> $\geq$ 15V, I <sub>D</sub> =7A
C <sub>iss</sub>	Input Capacitance	-	750	-	pF	V <sub>GS</sub> =0V, V <sub>DS</sub> =25V, f=1.0MHz
C <sub>oss</sub>	Output Capacitance	-	250	-	pF	
C <sub>rss</sub>	Reverse Transfer Capacitance	-	120	-	pF	
t <sub>d(on)</sub>	Turn-On Delay Time	-	-	40	ns	V <sub>DD</sub> =0.5 BV <sub>DSS</sub> , I <sub>D</sub> =14A, Z <sub>O</sub> =24 $\Omega$ (MOSFET switching times are essentially independent of operating temperature)
t <sub>r</sub>	Rise Time	-	-	260	ns	
t <sub>d(off)</sub>	Turn-Off Delay Time	-	-	200	ns	
t <sub>f</sub>	Fall Time	-	-	200	ns	
Q <sub>g</sub>	Total Gate Charge (Gate-Source Plus Gate-Drain)			22	nC	V <sub>GS</sub> =5V, I <sub>D</sub> =14A, V <sub>DS</sub> =0.8 Max. Rating (Gate charge is essentially independent of operating temperature)
Q <sub>gs</sub>	Gate-Source Charge	-	7	-	nC	
Q <sub>gd</sub>	Gate-Drain Charge	-	7	-	nC	

**THERMAL RESISTANCE**

Symbol	Characteristics		All	Units	Remark
R <sub>thJC</sub>	Junction-to-Case	MAX	3.0	K/W	
R <sub>thCS</sub>	Case-to-Sink	TYP	0.5	K/W	Mounting surface flat, smooth, and greased
R <sub>thJA</sub>	Junction-to-Ambient	MAX	62.5	K/W	Free Air Operation

Notes : (1) T<sub>J</sub>=25°C to 175°C(2) Pulse test : Pulse width  $\leq$  300 $\mu$ s, Duty Cycle  $\leq$  2%

(3) Repetitive rating : Pulse width limited by max. junction temperature

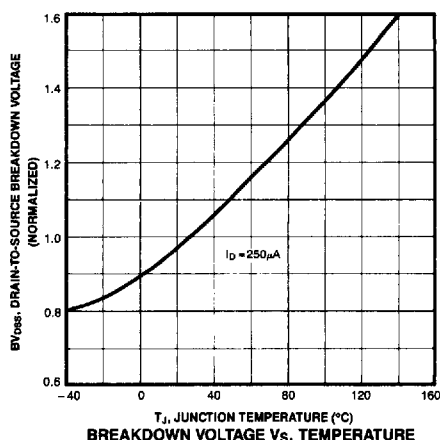
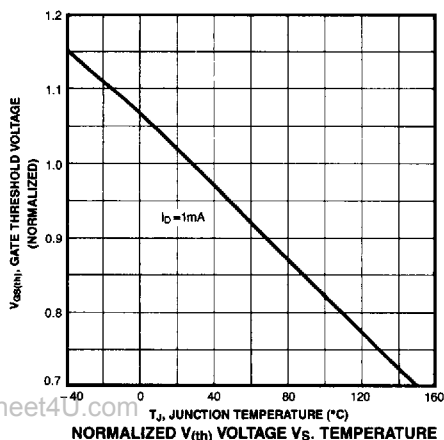
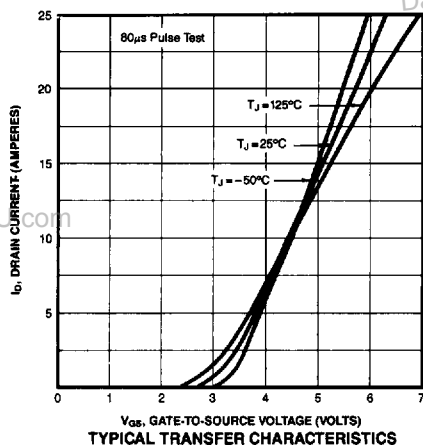
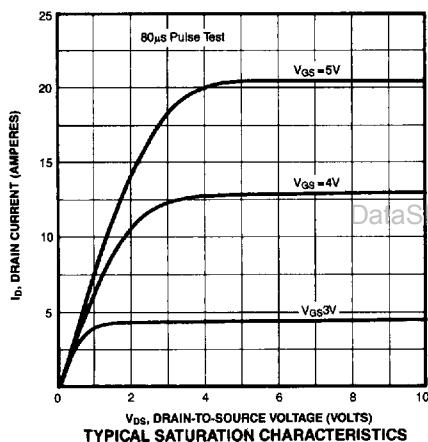
**IRLZ24/20**
**SOURCE-DRAIN DIODE RATING AND CHARACTERISTICS**

Symbol	Characteristic	Min	Typ	Max	Units	Test Condition
$I_S$	Continuous Source Current (Body Diode)	—	—	14	A	Modified MOSFET symbol showing the integral reverse P-N junction rectifier
$I_{SM}$	Pulse Source Current (Body Diode) (3)	—	—	56	A	
$V_{SD}$	Diode Forward Voltage (2)	—	—	1.8	V	$T_J = 25^\circ\text{C}$ , $I_S = 14.0\text{A}$ , $V_{GS} = 0\text{V}$
$t_{rr}$	Reverse Recovery Time	—	300	—	ns	$T_J = 25^\circ\text{C}$ , $I_F = 14.0\text{A}$ , $dI_F/dt = 100\text{A}/\mu\text{S}$

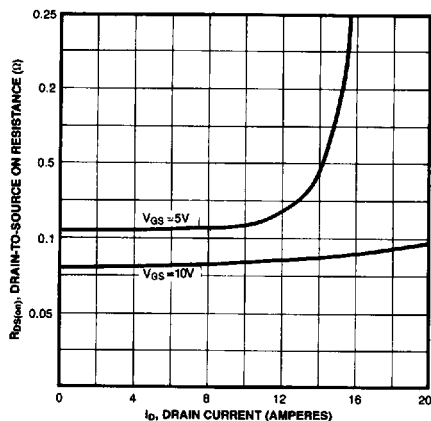
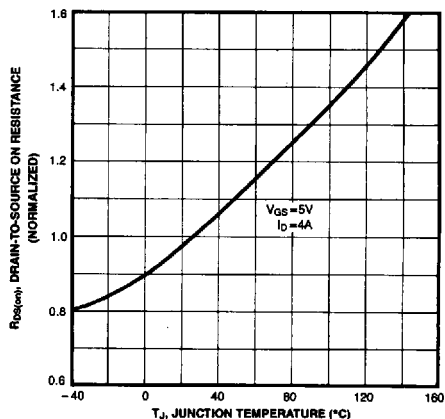
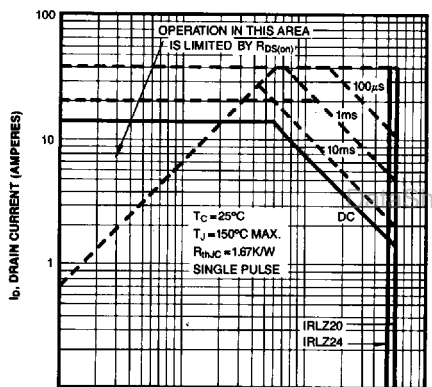
**Notes:** (1)  $T_J = 25^\circ\text{C}$  to  $175^\circ\text{C}$ 

 (2) Pulse test: Pulse width  $\leq 300\mu\text{s}$ , Duty Cycle  $\leq 2\%$ 

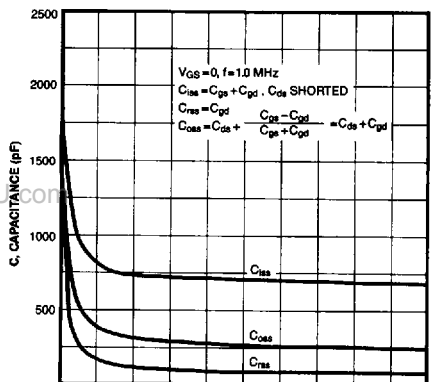
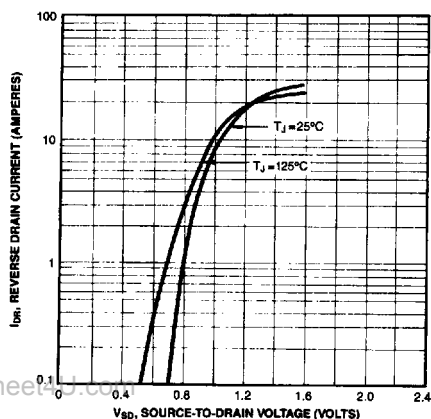
(3) Repetitive rating: Pulse width limited by max. junction temperature



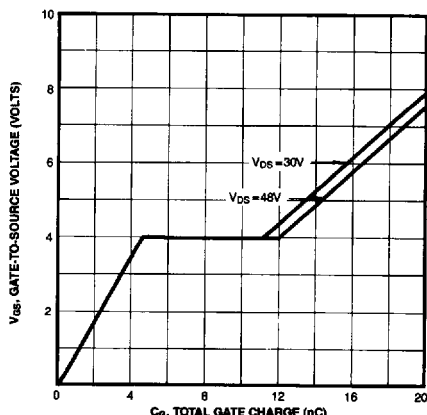
## IRLZ24/20

N-CHANNEL  
LOGIC LEVEL MOSFETTYPICAL ON-RESISTANCE  $V_S$  DRAIN CURRENTNORMALIZED ON-RESISTANCE  $V_S$  TEMPERATURE

MAXIMUM SAFE OPERATING AREA

TYPICAL CAPACITANCE  $V_S$  DRAIN TO SOURCE VOLTAGE

TYPICAL SOURCE-DRAIN DIODE FORWARD VOLTAGE

TYPICAL GATE CHARGE  $V_S$  GATE CHARGE (nC)